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- ☐ 1. On low-capture-power test generation for scan testing  
 Xiaoqing Wen; Yamashita, Y.; Kajihara, S.; Laung-Terng Wang; Saluja, K.K.; k  
 VLSI Test Symposium, 2005. Proceedings. 23rd IEEE  
 1-5 May 2005 Page(s):265 - 270  
 Digital Object Identifier 10.1109/VTs.2005.60  
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Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	35	((flip\$1flop or latch) near3 driv\$3) near3 (substitut\$3 or replac\$5)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/21 11:28
L2	2	"716"/\$.ccls. and (sta or slack) and ((positive with negative) with (flipflop or flip\$1flop or latch))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/21 12:28
L3	2	"20040049752"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/21 10:52
L5	45	((flip\$1flop or latch) with library) and ((IR or voltage) near3 drop\$4)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/21 10:58
L6	696	((flip\$1flop or latch) near3 driv\$3) with (substitut\$3 or replac\$5 or chang\$3)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/21 11:42
L7	3	716/5,6,10.ccls. and ((voltage or IR) near3 drop\$3) and slack and (delay near3 (calculat\$3 or determin\$5))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/21 11:26
L8	2	716/5,6,10.ccls. and ((voltage or IR) near3 drop\$3) and slack and (timing adj3 verification)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/21 11:27
L9	238	((flip\$1flop or latch) near3 driv\$3) near3 (substitut\$3 or replac\$5 or chang\$3)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/21 11:29
L10	5	((flip\$1flop or latch) near3 driv\$3) near3 (substitut\$3 or replac\$5 or chang\$3) and "716"/\$.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/21 11:29

L11	10	"716"/\$.ccls. and ((flip\$1flop or latch) near3 driv\$3) with (substitut\$3 or replac\$5 or chang\$3)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/21 11:42
L12	238	"716"/\$.ccls. and (sta or slack) and ((flipflop or flip\$1flop or latch))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/21 12:28
L15	23	(ir or (voltage) adj2 drop) and (sta or (static adj2 timing)) and (timing with simulat\$3)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/21 12:39
S2	10	("6028993" "6090150" "6216256" "6405350").pn.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/19 13:01
S3	143	716/5,6,10.ccls. and ((IR or voltage) adj2 drop)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/11 15:53
S4	39	716/5,6,10.ccls. and ((IR or voltage) adj2 drop) and (flip\$1flop or flipflop or latch)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/11 16:11
S6	8	716/5,6,10.ccls. and ((IR or voltage) adj2 drop) and (slack)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/11 16:16
S7	5	("5475605"   "6145428"   "6189131"   "6279142"   "6374394").PN. OR ("6629298").URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2005/07/11 16:14
S8	16	"716"/\$.ccls. and ((IR or voltage) adj2 drop) and (slack)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/19 10:32
S9	1	"716"/\$.ccls. and ((IR or voltage) adj2 drop) and (positive\$1negative)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/11 16:30

S10	6	"716"/\$.ccls. and (slack) and (positive\$1negative)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/12 11:51
S11	1	"716"/\$.ccls. and (slack) and ((positive with negative) adj3 (flipflop or flip\$1flop or latch))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/19 13:04
S12	2	"716"/\$.ccls. and (slack) and ((positive with negative) with (flipflop or flip\$1flop or latch))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/21 10:50
S20	8	("6792582" "6336207" "6311310" "5774367").pn.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/12 11:52
S21	20	("4580228"   "5349542"   "5404310"   "5537328"   "5602753"   "5638294"   "5663662"   "5666288"   "5724250"   "5764525"   "5768146"   "5796299"   "5801960"   "5852562"   "6000829").PN. OR ("6336207").URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2005/07/12 11:54
S22	17	("716"/\$.ccls. or "703"/\$.ccls. or "714"/\$.ccls.) and ((IR or voltage) adj2 drop) and (slack)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/19 10:38
S23	13	((IR) adj2 drop) and (slack)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/19 10:47
S24	5	"6564357".pn. "20020174409"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/19 10:46
S25	7	((voltage) adj2 drop) and (slack) and (timing with simulat\$3)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/19 10:51
S26	4	("6099580"   "6324678"   "6584596").PN. OR ("6820240").URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2005/07/19 10:49

S27	18	((voltage) adj2 drop) and (sta or (static adj timing)) and (timing with simulat\$3)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/21 12:38
S28	12	("4924430"   "5095454"   "5400270"   "5555187"   "5706205"   "5726902"   "5790830"   "5831869"   "5872716").PN. OR ("5983008").URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2005/07/19 11:21
S29	2	"6799310".pn.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/19 11:21
S30	1	("5774367").PN. OR ("6799310").URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2005/07/19 12:23
S31	42	iwanishi-nobufusa.in.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/19 12:24
S32	6	("5533197"   "5634001"   "5661413"   "5974247"   "6047247"   "6278964").PN. OR ("6795802").URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2005/07/19 12:42
S33	2	"6336205".pn.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/19 12:43
S34	4	"20040031008" "6675139".pn.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/19 13:02
S35	34	(slack) and ((positive with negative) with (flipflop or flip\$1flop or latch))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/19 13:04
S37	8	((flip\$1flop or latch) adj3 driv\$3) with substitut\$3	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/21 10:20

S38	430	((flip\$1flop or latch) with library)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/21 10:58
S39	5	((flip\$1flop or latch) with library) and (delay near3 calculat\$3) and ((voltage or ir) near3 drop)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/20 08:42
S40	2199	716/5,6.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/20 08:51
S41	118	716/5,6.ccls. and ((voltage or IR) near3 drop\$3)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/21 11:13
S42	16	("5446676"   "5471409"   "5535223"   "5598348"   "5648909"   "5657239"   "5872952"   "5878053"   "5930148"   "5949689"   "6088523"   "6219822"   "6253361"   "6269467"   "6301693").PN. OR ("6453443"). URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2005/07/20 11:21

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	1	((timing adj2 verification) and (slack adj2 sort) and (flip\$1flop adj2 driv\$3) and (layout adj2 modification) and (delay adj2 calculation)).CLM.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/21 13:45
L2	1	((timing adj2 verification) and (slack adj2 sort) and (flip\$1flop adj2 substitution) and (layout adj2 modification) and (delay adj2 calculation)).CLM.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/21 13:45